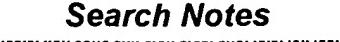


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/644,588	SANCHEZ ET AL.
	<b>Examiner</b> Amy A. Lewis	<b>Art Unit</b> 1614

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner